

Features

- Typ. R_{DS(on)} = 188 mΩ
- Ultra Low Gate Charge (Typ. Q_q = 78 nC)
- Low E_{oss} (Typ. 7.5 uJ @ 400 V)
- Low Effective Output Capacitance (Typ. C_{oss(eff.)} = 304 pF)
- 100% Avalanche Tested
- RoHS Compliant
- · ESD Improved Capability

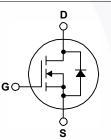
Applications

- AC-DC Power Supply
- LED Lighting

Description

SuperFET[®] II MOSFET is Fairchild Semiconductor's brand-new high voltage super-junction (SJ) MOSFET family that is utilizing charge balance technology for outstanding low on-resistance and lower gate charge performance. This technology is tailored to minimize conduction loss, provide superior switching performance, dv/dt rate and higher avalanche energy. Consequently, SuperFET II MOSFET is very suitable for the switching power applications such as PFC, server/telecom power, FPD TV power, ATX power and industrial power applications.





Absolute Maximum Ratings T_C = 25°C unless otherwise noted.

Symbol	Parameter			FCPF220N80	Unit	
V _{DSS}	Drain to Source Voltage		800	V		
V _{GSS}		- DC	- DC		V	
	Gate to Source Voltage	- AC	(f >1 Hz)	±30	V	
ID	Drain Current	- Continuous (T _C = 25 ^o C)		23*	Α	
		- Continuous (T _C = 100 ^o C)		14.6*	A	
I _{DM}	Drain Current	- Pulsed (Note 1)		57*	Α	
E _{AS}	Single Pulsed Avalanche Energy		(Note 2)	645	mJ	
I _{AR}	Avalanche Current	(Note 1)	4.6	Α		
E _{AR}	Repetitive Avalanche Energy	(Note 1)	27.8	mJ		
dv/dt	MOSFET dv/dt			100	Mag	
	Peak Diode Recovery dv/dt (Note 3)			20	V/ns	
P _D	Dower Dissinction	(T _C = 25°C)		44	W	
	Power Dissipation	- Derate Above 25°C		0.35	W/ºC	
T _J , T _{STG}	Operating and Storage Temperature Range			-55 to +150	°C	
Τ _L	Maximum Lead Temperature for Soldering, 1/8" from Case for 5 Seconds			300	°C	

Thermal Characteristics

Symbol	Parameter	FCPF220N80	Unit
$R_{ ext{ heta}JC}$	Thermal Resistance, Junction to Case, Max.	2.8	°C/W
$R_{ extsf{ heta}JA}$	Thermal Resistance, Junction to Ambient, Max.	62.5	°C/W

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Symbol Off Character BV _{DSS} D ABV _{DSS} B	Characteristics T _C = 25 ^o Parameter	TO-220F	Packing Method Tube erwise noted. Test Conditions	N/A		N/A	50	units
Symbol Off Character BV _{DSS} D ΔBV _{DSS} B	Parameter ristics	C unless oth						
Symbol Off Character BV _{DSS} D ΔBV _{DSS} B	Parameter ristics	C unless oth						
Dff Character BV _{DSS} D ABV _{DSS} B	ristics		Test Conditions		Mim	Turn	Max	l lmit
BV _{DSS} D ABV _{DSS} B					Min.	Тур.	Max.	Unit
ΔBV _{DSS} B	rain to Source Preskdown Malta							
	rain to Source preakdown voltag	je V _G	_S = 0 V, I _D = 1 mA, T _J =	25°C	800	-	-	V
	Breakdown Voltage Temperature Coefficient		$I_D = 1$ mA, Referenced to 25°C		-	0.8	-	V/ºC
. 7	ara Cata Valtaga Drain Current	VDS	V _{DS} = 800 V, V _{GS} = 0 V V _{DS} = 640 V, T _C = 125°C		-	-	25	
I _{DSS}	ero Gate Voltage Drain Current	VDS			-	-	250	μΑ
I _{GSS} G	Gate to Body Leakage Current		V _{GS} = ±20 V, V _{DS} = 0 V		-	-	±100	nA
On Character	istics							
	ate Threshold Voltage	Vo	_S = V _{DS} , I _D = 2.3 mA		2.5		4.5	V
	tatic Drain to Source On Resistar	-	$s = 10 \text{ V}, I_D = 11.5 \text{ A}$		-	188	220	mΩ
	orward Transconductance		$s = 20 \text{ V}, I_D = 11.5 \text{ A}$		-	25	-	S
9F5			5 _0 ,, 0			20		0
Dynamic Cha	racteristics							
C _{iss} In	put Capacitance		V _{DS} = 100 V, V _{GS} = 0 V, f = 1 MHz		-	3430	4560	pF
	utput Capacitance				-	100	135	pF
	everse Transfer Capacitance	T =			-	0.3	-	pF
	utput Capacitance	VD	_S = 480 V, V _{GS} = 0 V, f	= 1 MHz	-	49	-	pF
	ffective Output Capacitance		_S = 0 V to 480 V, V _{GS} =		-	304	-	pF
000(011)	otal Gate Charge at 10V		V _{DS} = 640 V, I _D = 23 A, V _{GS} = 10 V		-	78	105	nC
9(101)	ate to Source Gate Charge				-	16	-	nC
90	Gate to Drain "Miller" Charge		(Note 4)			28	-	nC
	quivalent Series Resistance	f =	1 MHz		-	0.78	-	Ω
				I				1
	aracteristics					- T T		
=(=)	urn-On Delay Time		V_{DD} = 400 V, I _D = 23 A, V _{GS} = 10 V, R _g = 4.7 Ω		-	27	64	ns
•	urn-On Rise Time				- /	19	48	ns
a(011)	urn-Off Delay Time	V GS			-	75	160	ns
t _f Ti	urn-Off Fall Time			(Note 4)	-	2.6	15	ns
Drain-Source	Diode Characteristics							
	aximum Continuous Drain to Sou	irce Diode Ec			-	_	23	А
					-	_	57	A
OW	Maximum Pulsed Drain to Source Diode Drain to Source Diode Forward Voltage		V_{GS} = 0 V, I _{SD} = 23 A		-		1.2	V
	everse Recovery Time				-	560	1.2	ns
t _{rr} Re	everse Recovery Charge		_S = 0 V, I _{SD} = 23 A, /dt = 100 A/µs	+		14	-	μC

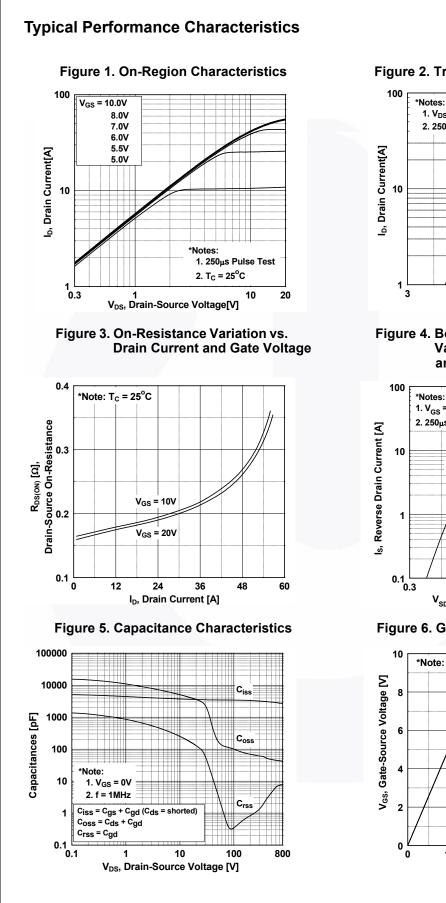
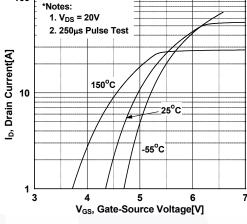


Figure 2. Transfer Characteristics





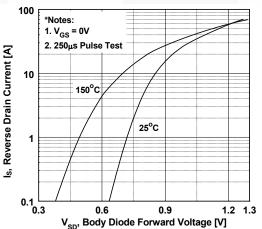
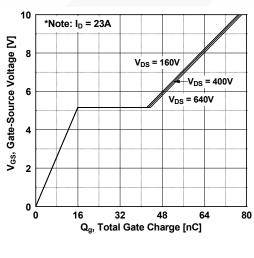
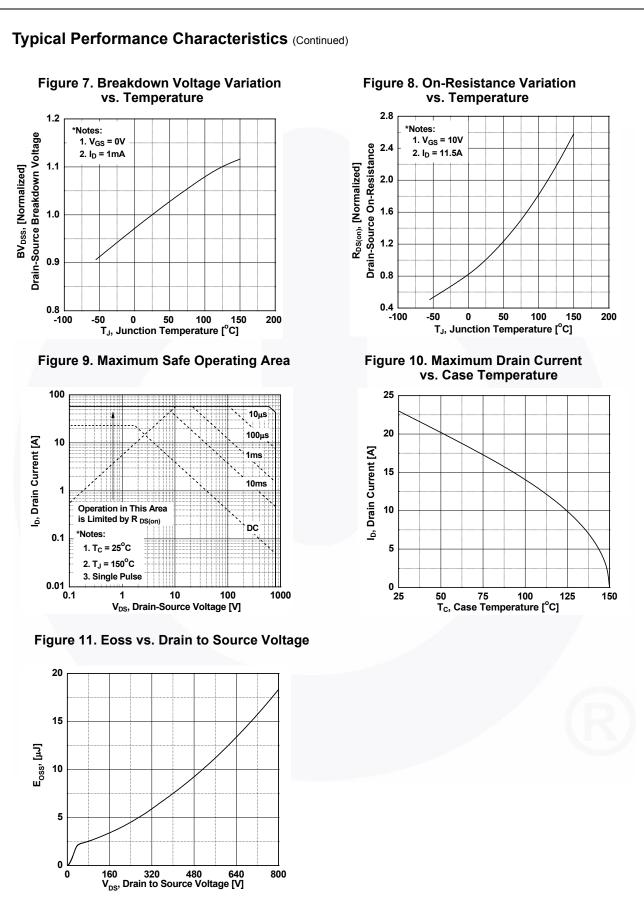


Figure 6. Gate Charge Characteristics

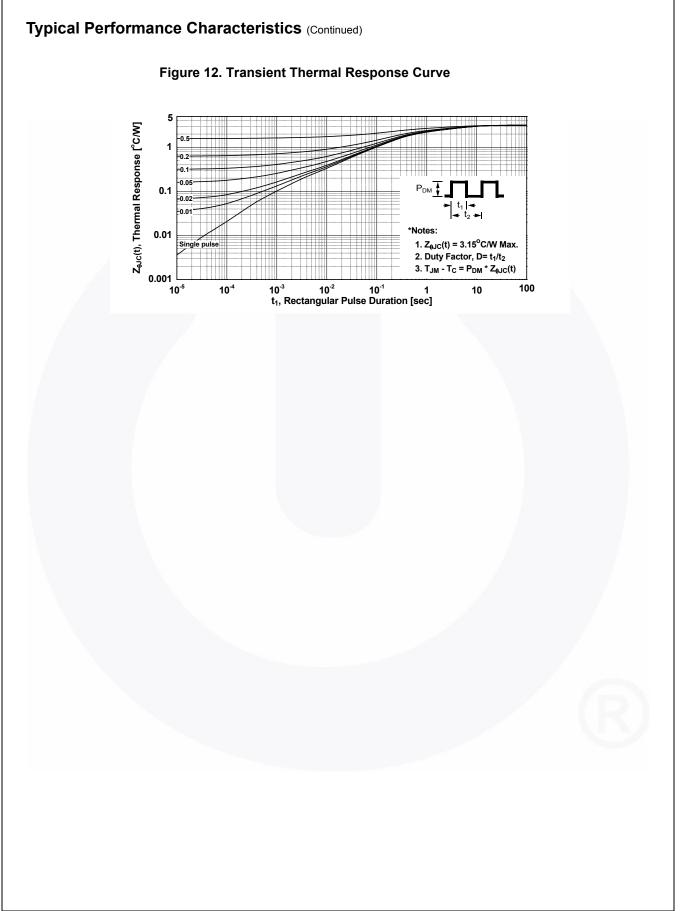


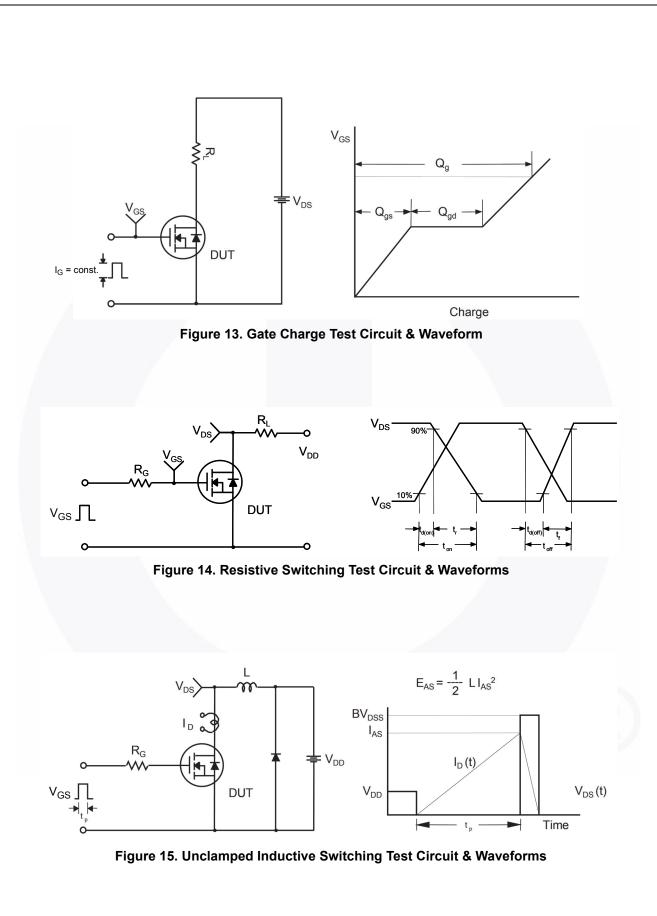




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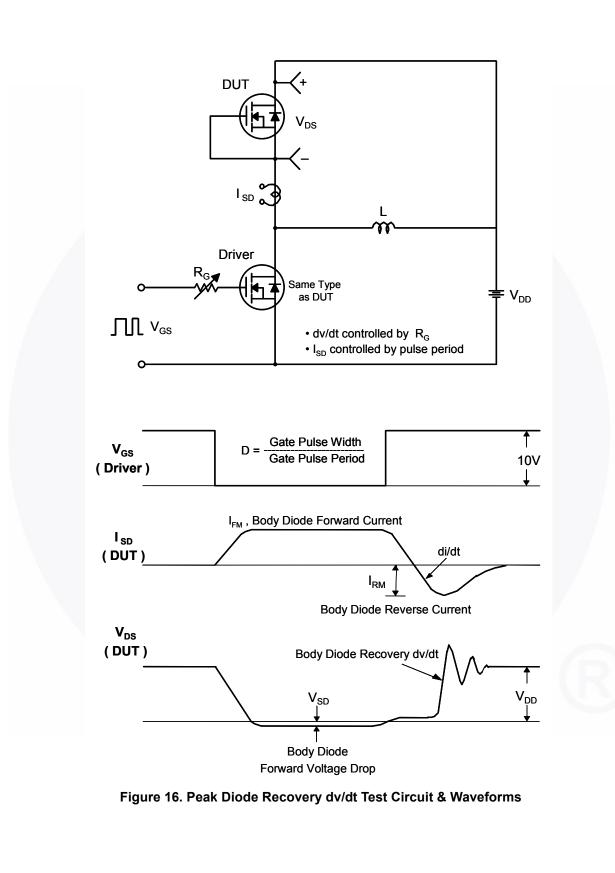
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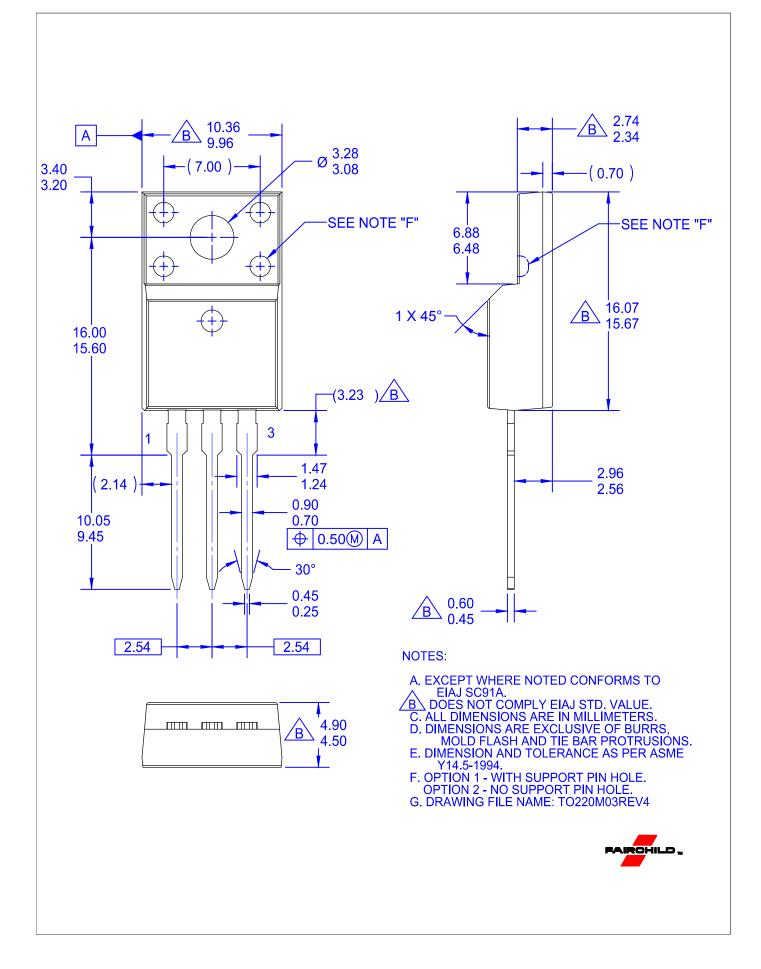




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